

**N- AND P-CHANNEL ENHANCEMENT  
 MODE POWER MOSFET**

SOT-26

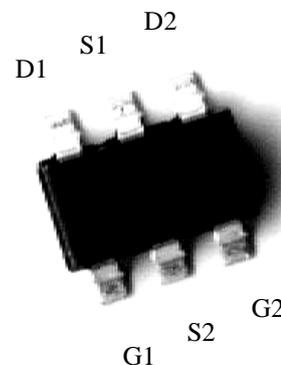
**Features:**

- Simple drive requirement
- Low gate charge
- Low on-resistance
- Fast switching speed
- Pb-free lead plating and halogen-free package

**Description**

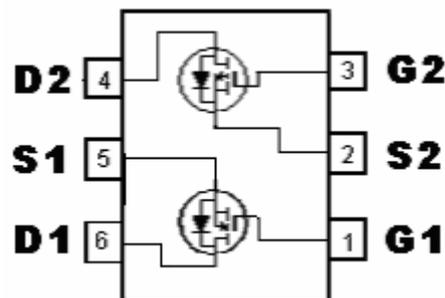
The KW3585N6 consists of a N-channel and a P-channel enhancement-mode MOSFET in a single SOT-26 package, providing the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The SOT-26 package is universally preferred for all commercial-industrial surface mount applications.



**Equivalent Circuit**

KW3585N6



G : Gate  
 S : Source  
 D : Drain

	N-CH	P-CH
BV <sub>DSS</sub>	20V	-20V
I <sub>D</sub>	4.5A(V <sub>GS</sub> =4.5V)	-3A(V <sub>GS</sub> =-4.5 V)
R <sub>DS(on)</sub> (TYP.)	27mΩ (V <sub>GS</sub> =4.5V)	78mΩ (V <sub>GS</sub> =-4.5V)
	37mΩ (V <sub>GS</sub> =2.5V)	115mΩ (V <sub>GS</sub> =-2.5V)
	82mΩ (V <sub>GS</sub> =1.5V)	280mΩ (V <sub>GS</sub> =-1.5V)

**Absolute Maximum Ratings** (Ta=25°C)

Parameter	Symbol	Limits		Unit
		N-channel	P-channel	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	20	-20	V
Gate-Source Voltage	V <sub>GS</sub>	±12	±12	V
Continuous Drain Current @T <sub>A</sub> =25 °C (Note 1)	I <sub>D</sub>	4.5	-3	A
Continuous Drain Current @T <sub>A</sub> =70 °C (Note 1)	I <sub>D</sub>	3.6	-2.4	A
Pulsed Drain Current (Note 2)	I <sub>DM</sub>	20	-20	A
Total Power Dissipation (Note 1)	P <sub>d</sub>	1.14		W
Linear Derating Factor		0.01		W / °C
Operating Junction and Storage Temperature	T <sub>j</sub> , T <sub>stg</sub>	-55~+150		°C

Note : 1.Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board, t≤5 sec  
 2.Pulse width limited by maximum junction temperature

**N-Channel Electrical Characteristics** (T<sub>j</sub>=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	20	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =250μA
ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	-	0.02	-	V/°C	Reference to 25°C, I <sub>D</sub> =1mA
V <sub>GS(th)</sub>	0.5	0.7	1.2	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =250μA
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	1	μA	V <sub>DS</sub> =20V, V <sub>GS</sub> =0
	-	-	10		V <sub>DS</sub> =16V, V <sub>GS</sub> =0, T <sub>j</sub> =70°C
*R <sub>DS(ON)</sub>	-	27	40	mΩ	I <sub>D</sub> =3.5A, V <sub>GS</sub> =4.5V
	-	37	50		I <sub>D</sub> =1.2A, V <sub>GS</sub> =2.5V
	-	82	105		I <sub>D</sub> =0.5A, V <sub>GS</sub> =1.5V
*G <sub>FS</sub>	-	7	-	S	V <sub>DS</sub> =5V, I <sub>D</sub> =3A
<b>Dynamic</b>					
C <sub>iSS</sub>	-	423	-	pF	V <sub>DS</sub> =20V, V <sub>GS</sub> =0, f=1MHz
C <sub>oSS</sub>	-	50	-		
C <sub>rSS</sub>	-	48	-		
*t <sub>d(ON)</sub>	-	6	-	ns	V <sub>DS</sub> =15V, I <sub>D</sub> =1A, V <sub>GS</sub> =5V, R <sub>G</sub> =3.3Ω, R <sub>D</sub> =15Ω
*t <sub>r</sub>	-	8	-		
*t <sub>d(OFF)</sub>	-	11	-		
*t <sub>f</sub>	-	10	-		
*Q <sub>g</sub>	-	6	-	nC	V <sub>DS</sub> =16V, I <sub>D</sub> =3A, V <sub>GS</sub> =4.5V
*Q <sub>gs</sub>	-	0.8	-		
*Q <sub>gd</sub>	-	2.5	-		
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	0.77	1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =1.2A
*t <sub>rr</sub>	-	16	-	ns	I <sub>S</sub> =3A, V <sub>GS</sub> =0V, dI/dt=100A/μs
*Q <sub>rr</sub>	-	8	-	nC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%

**P-Channel Electrical Characteristics** (T<sub>j</sub>=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
<b>Static</b>					
BV <sub>DSS</sub>	-20	-	-	V	V <sub>GS</sub> =0, I <sub>D</sub> =-250μA
ΔBV <sub>DSS</sub> /ΔT <sub>j</sub>	-	-0.01	-	V/°C	Reference to 25°C, I <sub>D</sub> =-1mA
V <sub>GS(th)</sub>	-	-0.8	-1.2	V	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA
I <sub>GSS</sub>	-	-	±100	nA	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0
I <sub>DSS</sub>	-	-	-1	μA	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0
	-	-	-25		V <sub>DS</sub> =-16V, V <sub>GS</sub> =0, T <sub>j</sub> =70°C
*R <sub>DS(ON)</sub>	-	78	105	mΩ	I <sub>D</sub> =-2.5A, V <sub>GS</sub> =-4.5V
	-	115	150		I <sub>D</sub> =-2A, V <sub>GS</sub> =-2.5V
	-	280	350		I <sub>D</sub> =-0.5A, V <sub>GS</sub> =-1.5V
*G <sub>FS</sub>	-	5	-	S	V <sub>DS</sub> =-5V, I <sub>D</sub> =-2A
<b>Dynamic</b>					
C <sub>iSS</sub>	-	429	-	pF	V <sub>DS</sub> =-20V, V <sub>GS</sub> =0, f=1MHz
C <sub>oSS</sub>	-	45	-		
C <sub>rSS</sub>	-	41	-		
*t <sub>d(ON)</sub>	-	6	-	ns	V <sub>DS</sub> =-10V, I <sub>D</sub> =-1A, V <sub>GS</sub> =-10V, R <sub>G</sub> =3.3Ω, R <sub>D</sub> =10Ω
*t <sub>r</sub>	-	17	-		
*t <sub>d(OFF)</sub>	-	16	-		
*t <sub>f</sub>	-	5	-		
*Q <sub>g</sub>	-	6	-	nC	V <sub>DS</sub> =-16V, I <sub>D</sub> =-2A, V <sub>GS</sub> =-4.5V
*Q <sub>gs</sub>	-	0.8	-		
*Q <sub>gd</sub>	-	2.4	-		
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	-0.82	-1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =-1.2A
*t <sub>rr</sub>	-	20	-	ns	I <sub>S</sub> =-2A, V <sub>GS</sub> =0V, dI/dt=100A/μs
*Q <sub>rr</sub>	-	15	-	nC	

\*Pulse Test : Pulse Width ≤300μs, Duty Cycle ≤2%

**Thermal Data**

Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	R <sub>θJC</sub>	80	°C/W
Thermal Resistance, Junction-to-ambient, max	R <sub>θJA</sub>	110 (Note)	°C/W

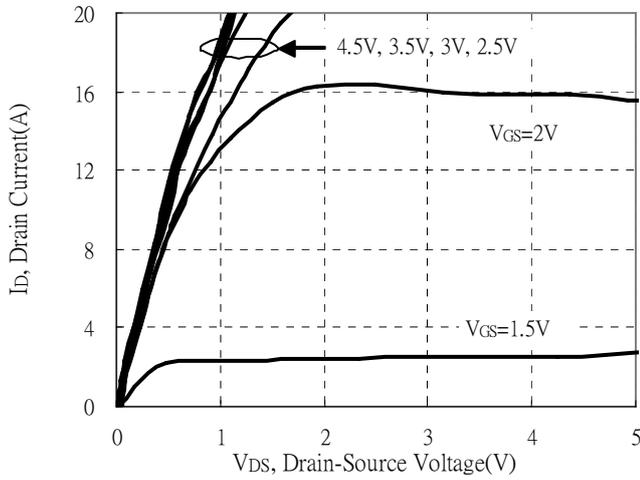
Note : Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board, t ≤5 sec; 180°C/W when mounted on minimum copper pad

**Ordering Information**

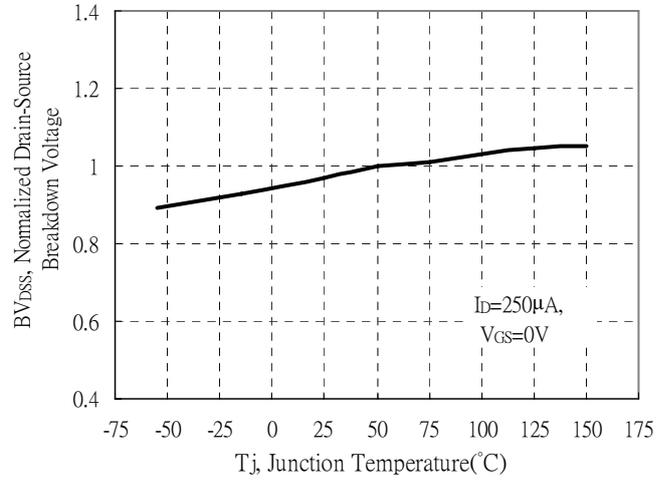
Device	Package	Shipping
KW3585N6-T1-G	SOT-26 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel

## N-channel Typical Characteristics

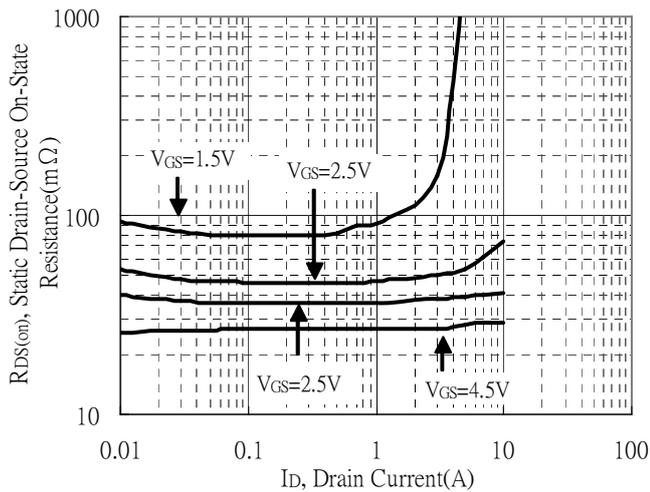
Typical Output Characteristics



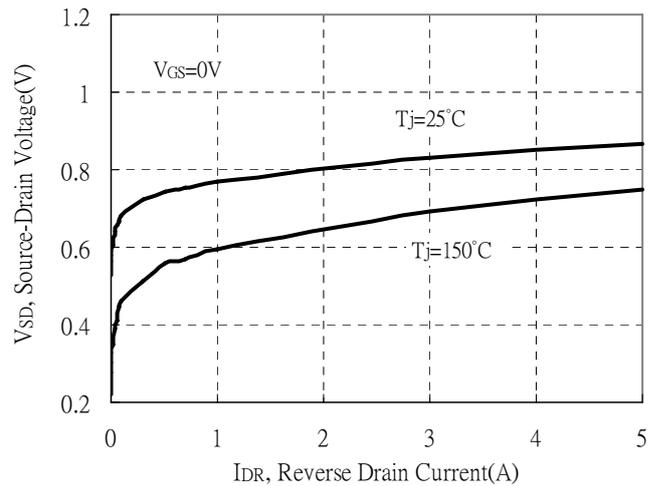
Breakdown Voltage vs Ambient Temperature



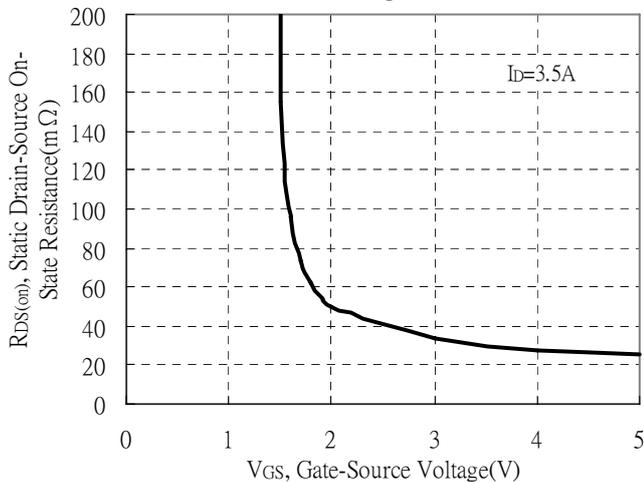
Static Drain-Source On-State resistance vs Drain Current



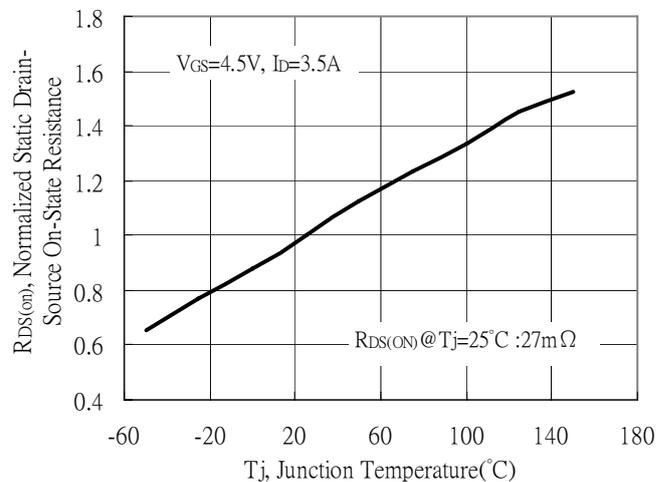
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

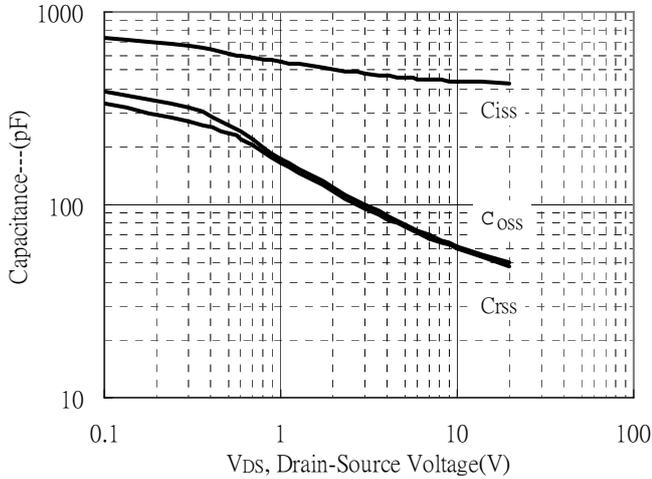


Drain-Source On-State Resistance vs Junction Temperature

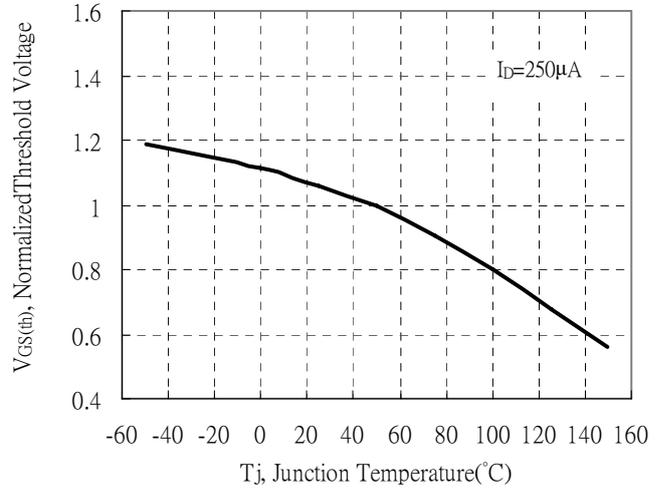


## N-channel Typical Characteristics(Cont.)

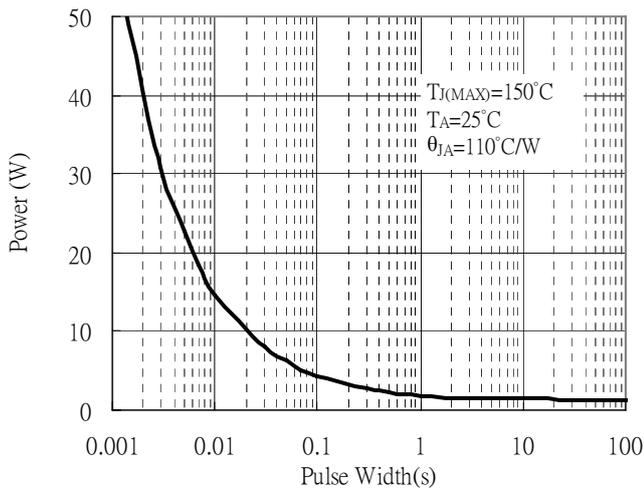
Capacitance vs Drain-to-Source Voltage



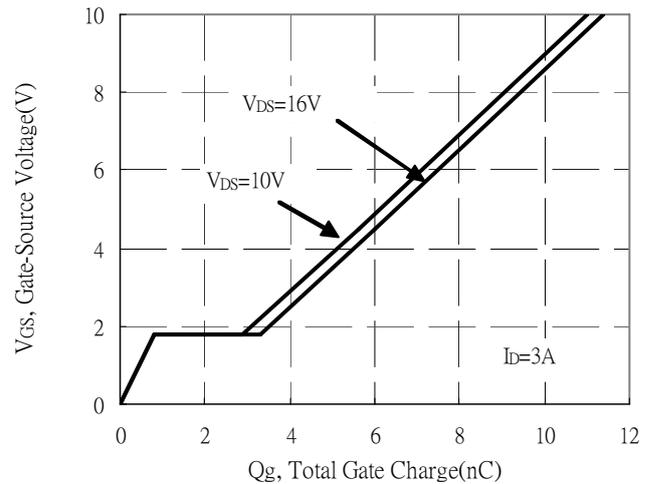
Threshold Voltage vs Junction Temperature



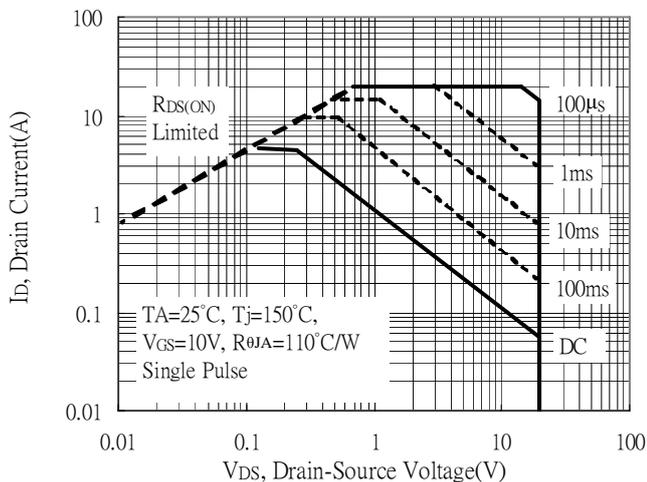
Single Pulse Power Rating, Junction to Ambient



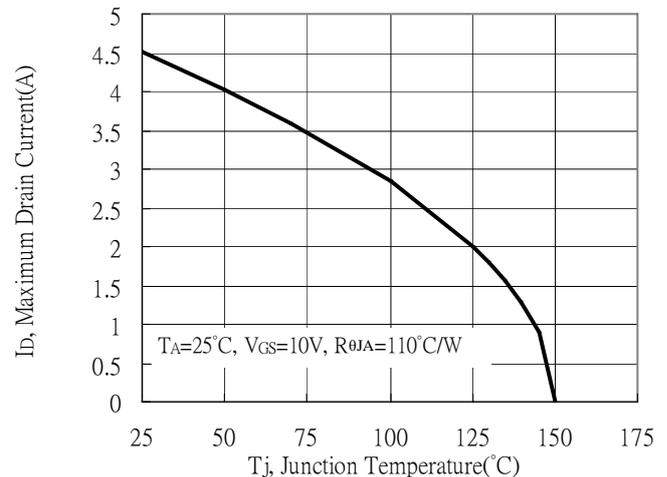
Gate Charge Characteristics



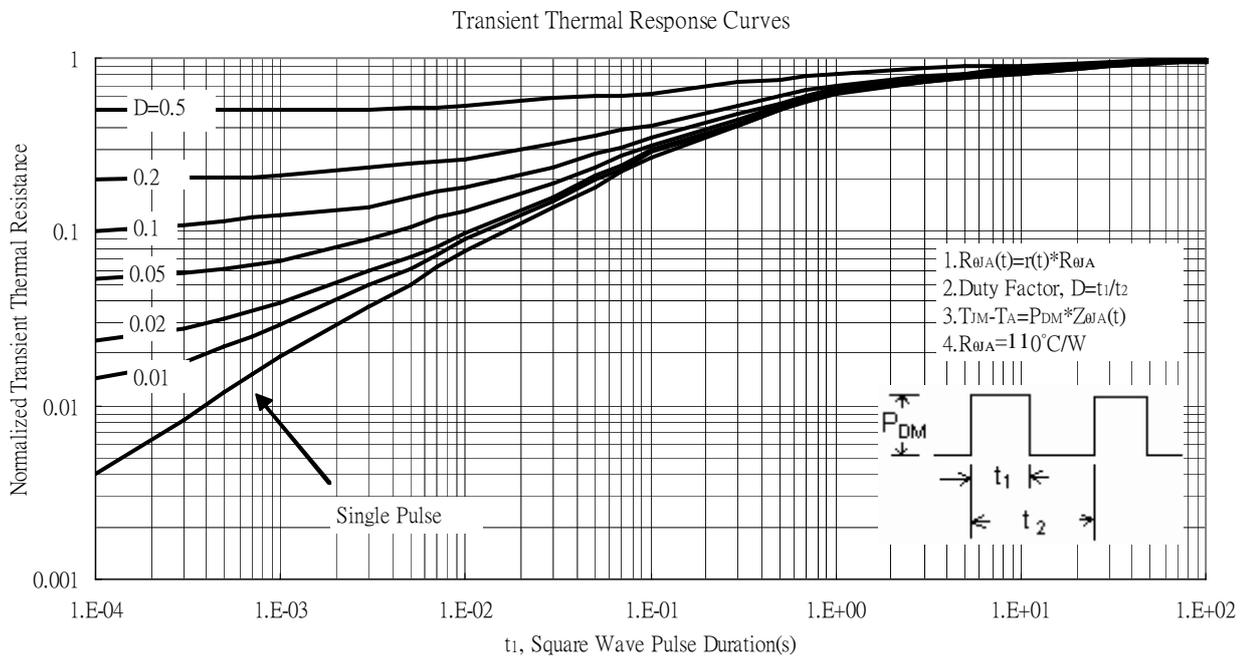
Maximum Safe Operating Area



Maximum Drain Current vs Junction Temperature

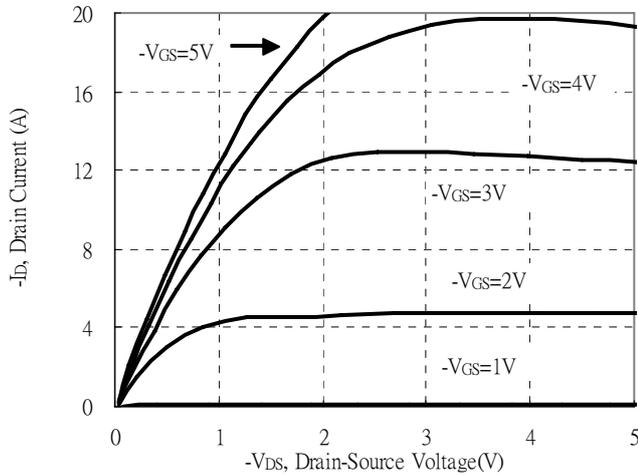


### N-channel Typical Characteristics(Cont.)

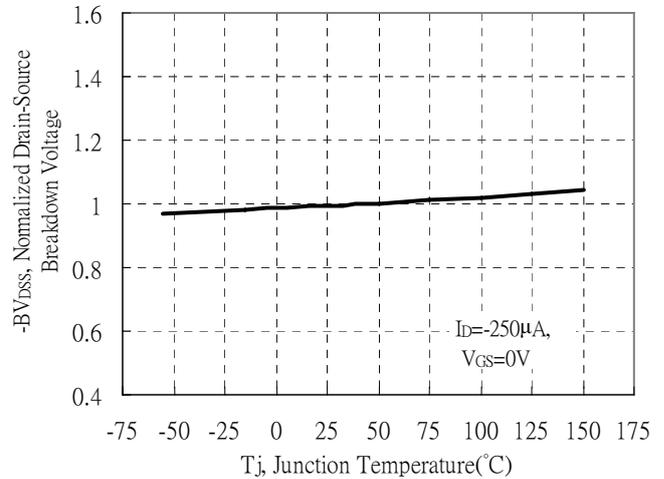


## P-channel Typical Characteristics

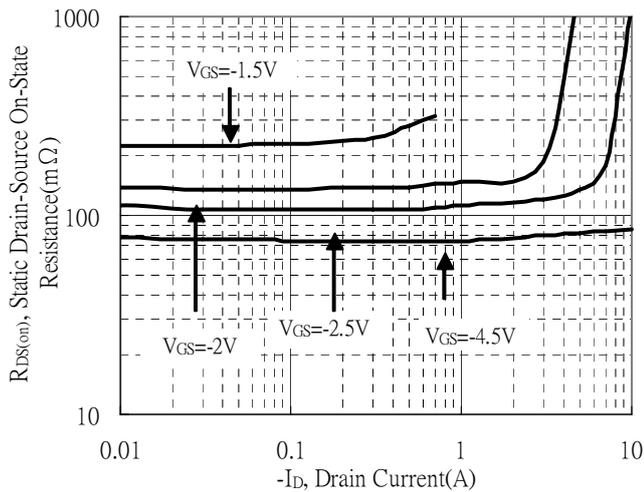
Typical Output Characteristics



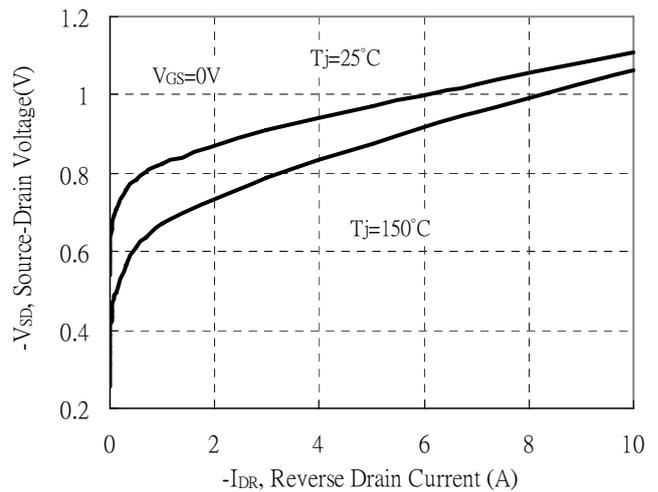
Brekdown Voltage vs Ambient Temperature



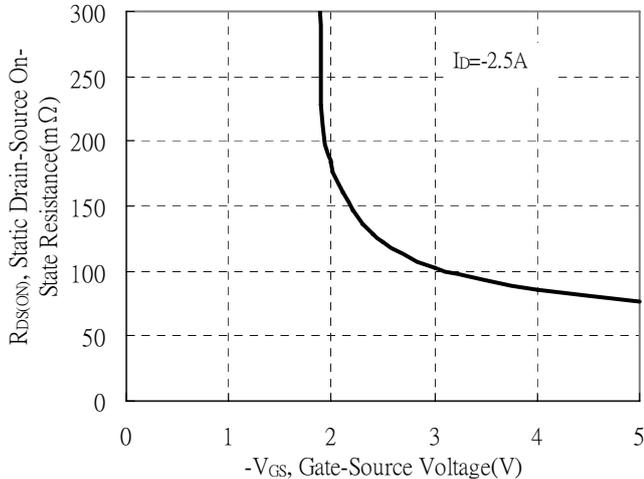
Static Drain-Source On-State resistance vs Drain Current



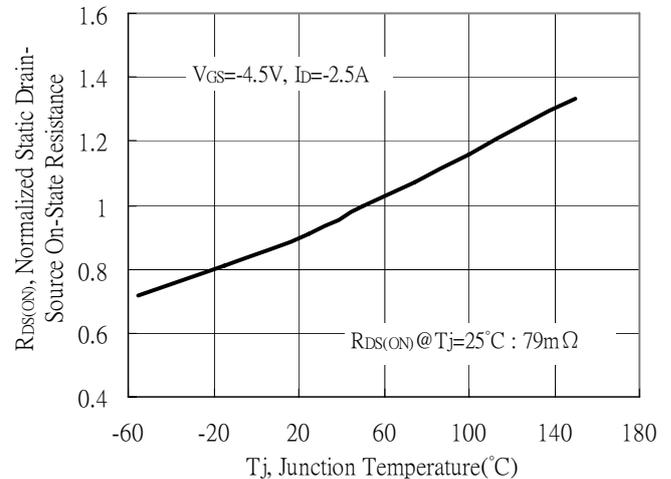
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

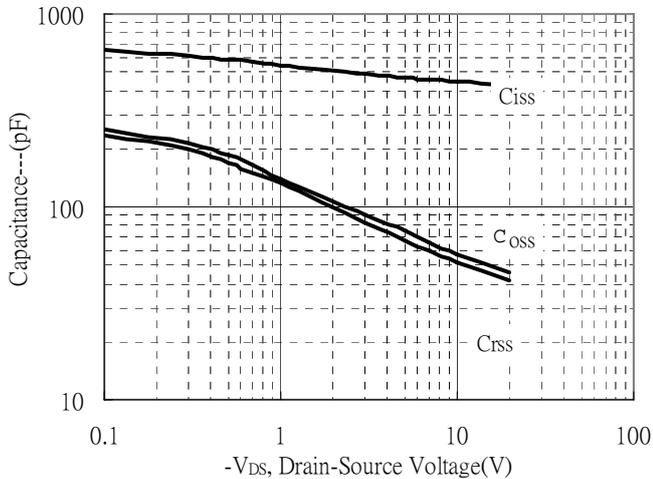


Drain-Source On-State Resistance vs Junction Temperature

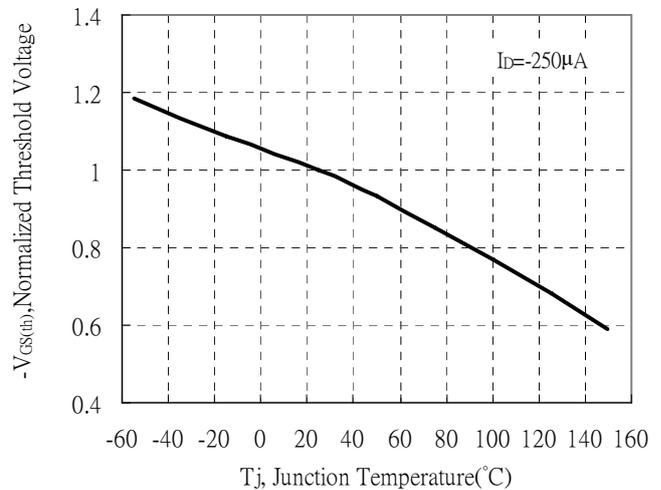


**P-channel Typical Characteristics(Cont.)**

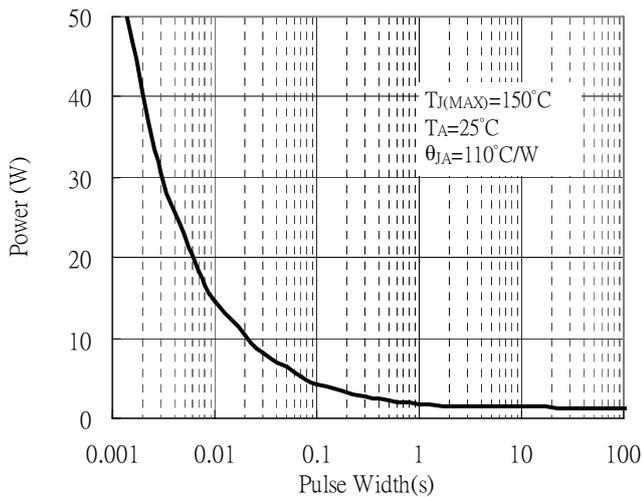
Capacitance vs Drain-to-Source Voltage



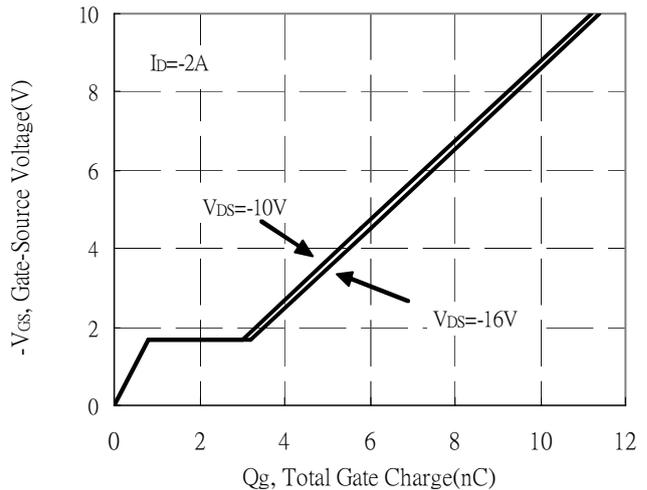
Threshold Voltage vs Junction Temperature



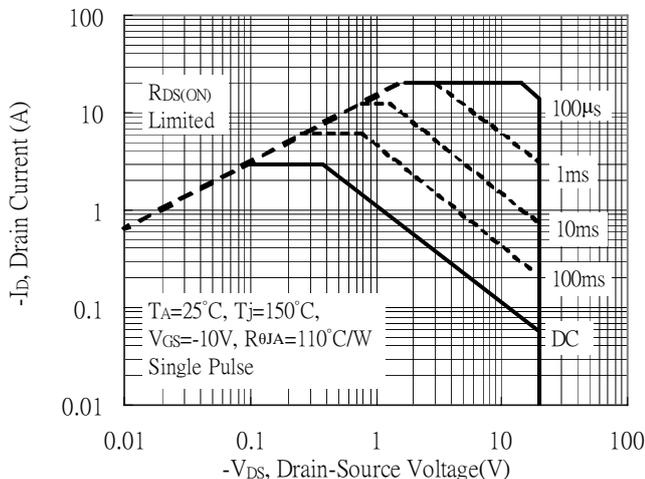
Single Pulse Power Rating, Junction to Ambient



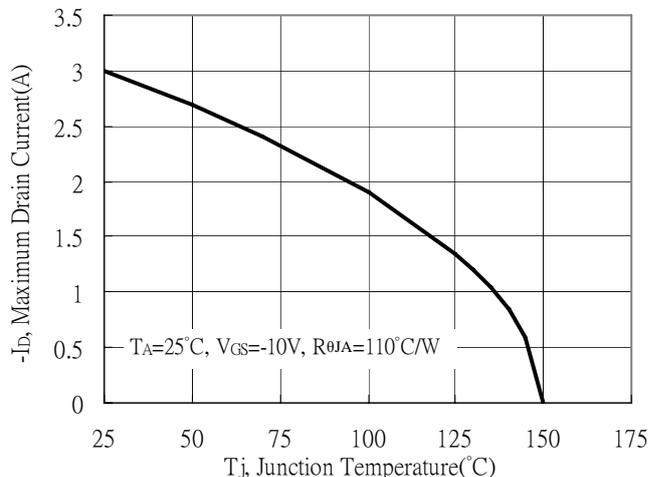
Gate Charge Characteristics



Maximum Safe Operating Area

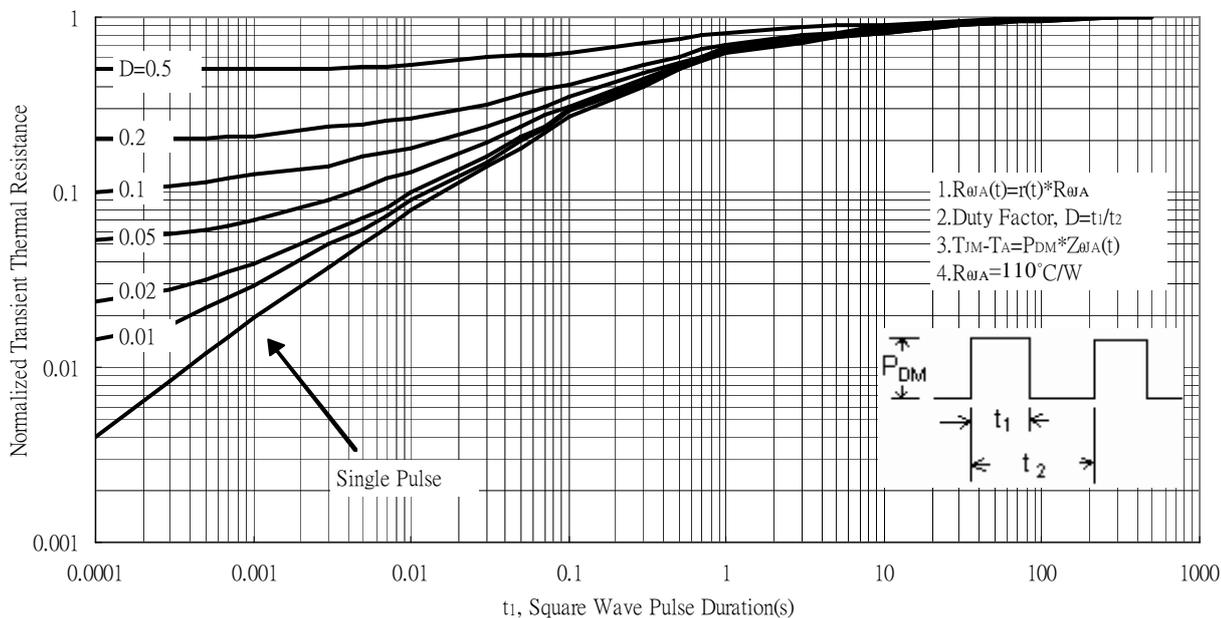


Maximum Drain Current vs Junction Temperature

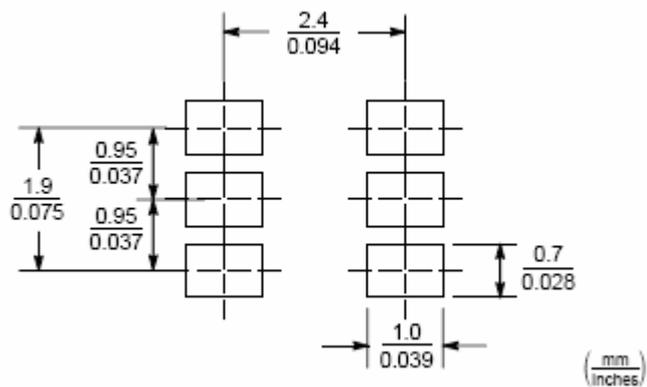


## P-channel Typical Characteristics(Cont.)

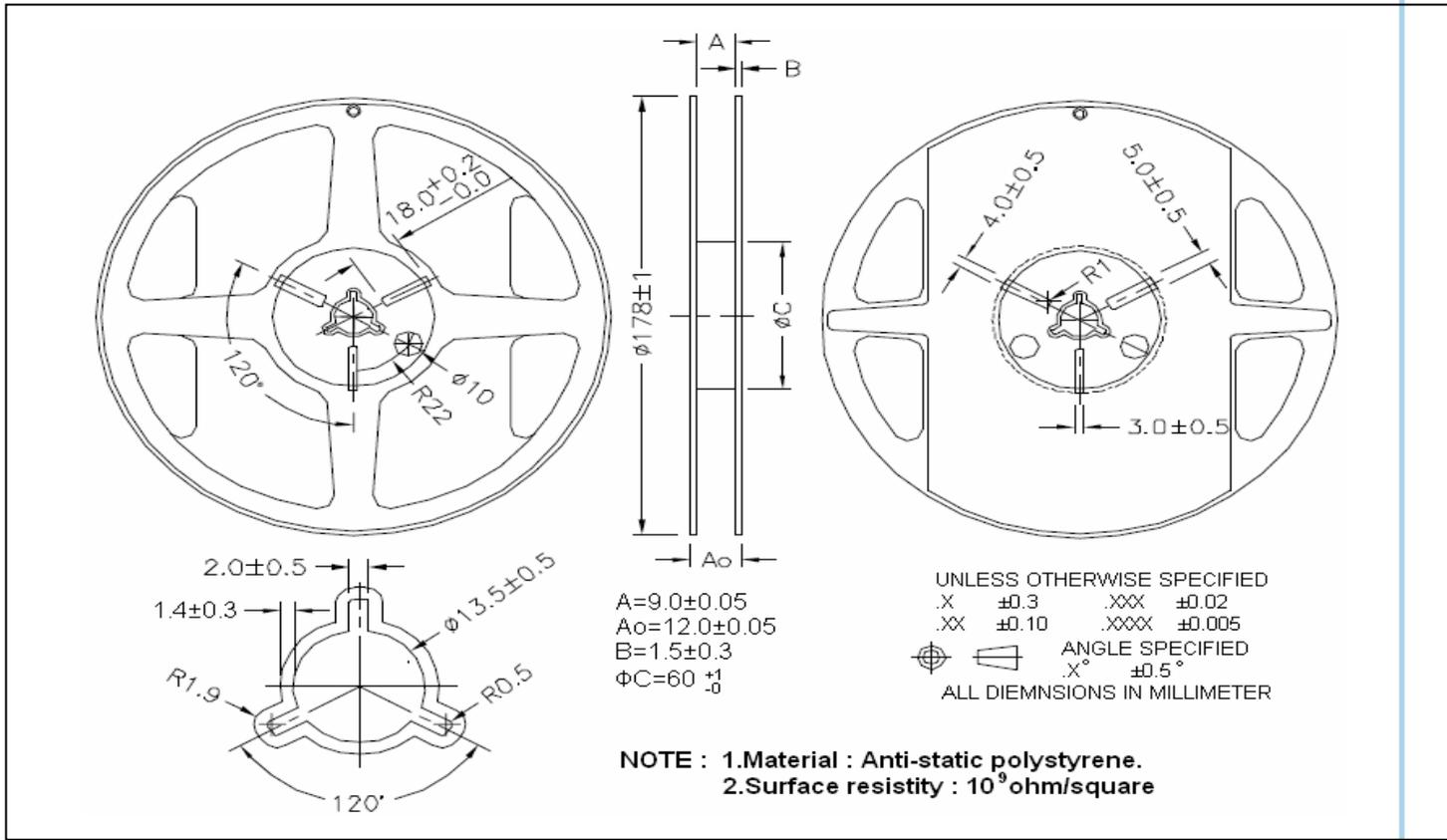
Transient Thermal Response Curves



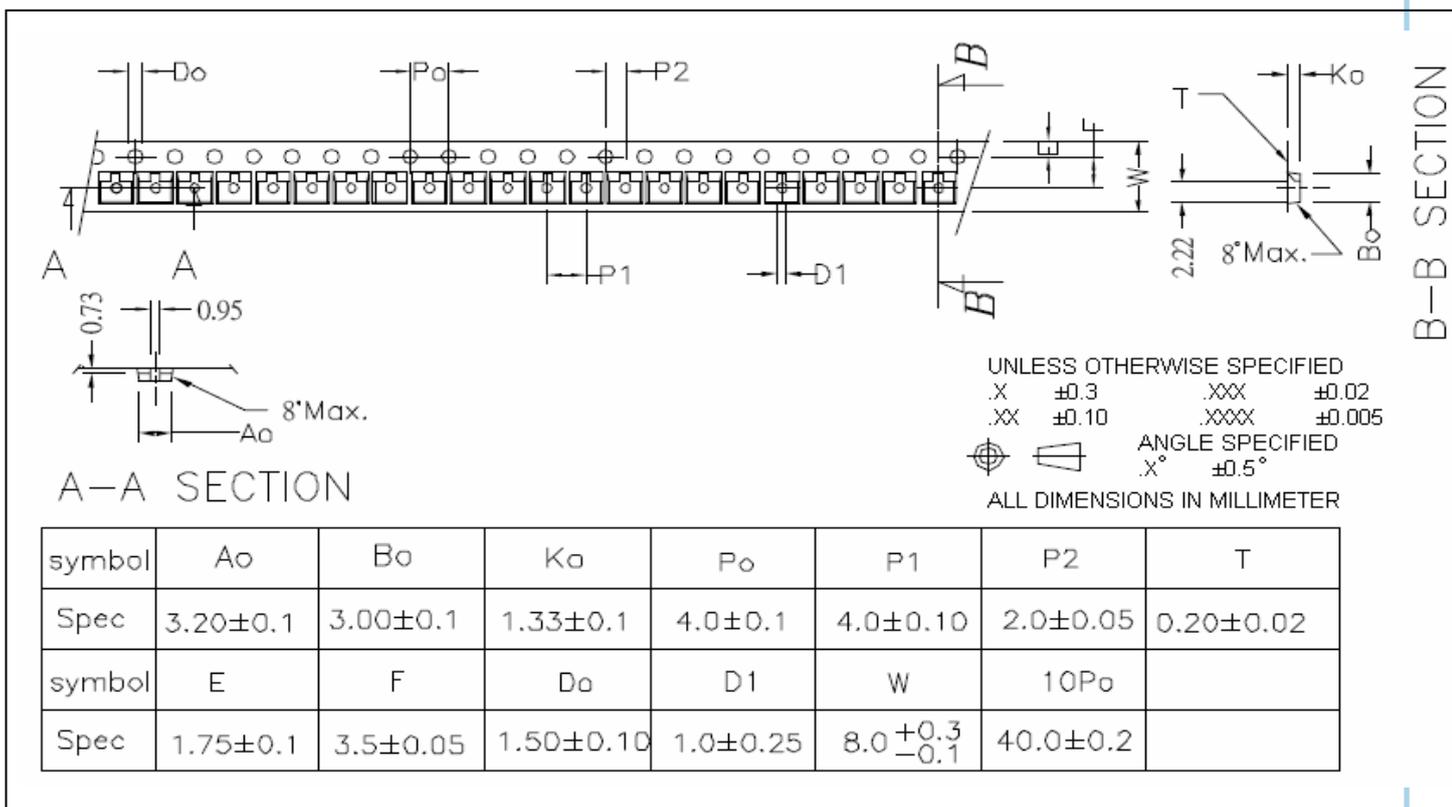
## Recommended Soldering Footprint



**Reel Dimension**



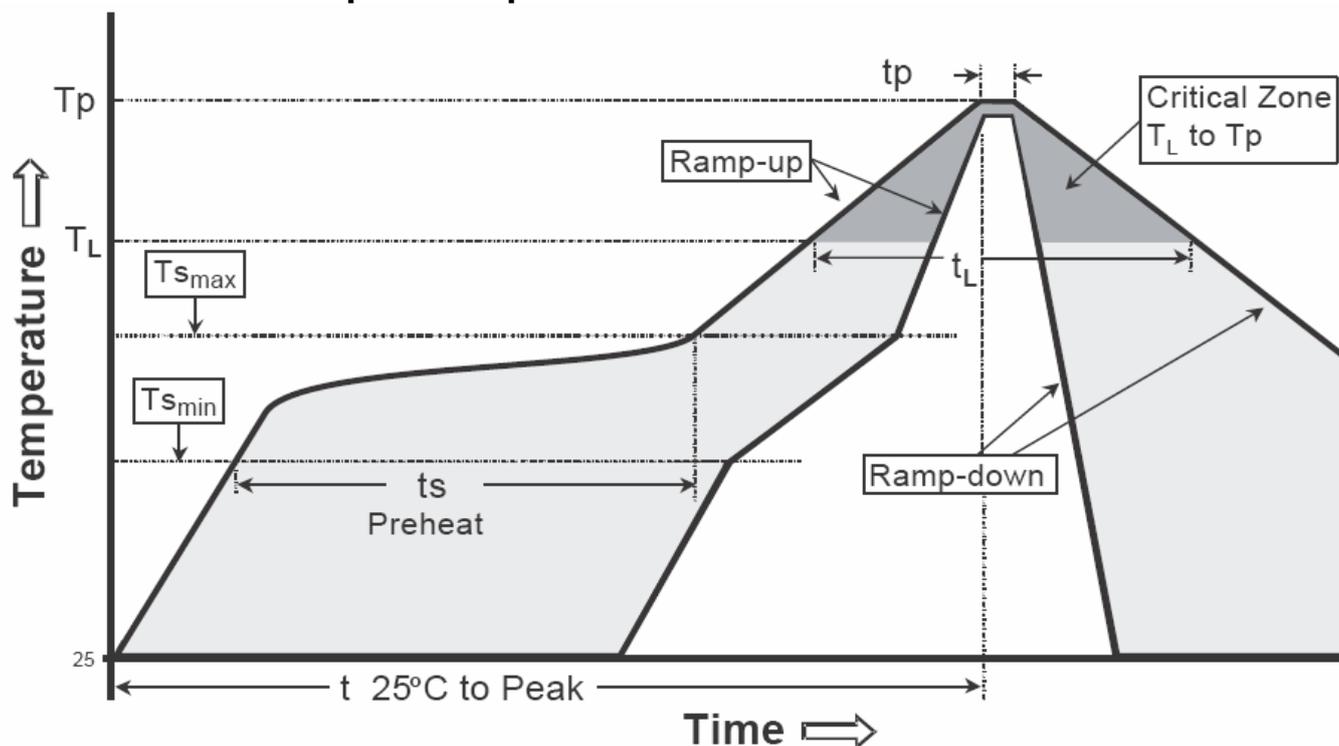
**Carrier Tape Dimension**



**Recommended wave soldering condition**

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

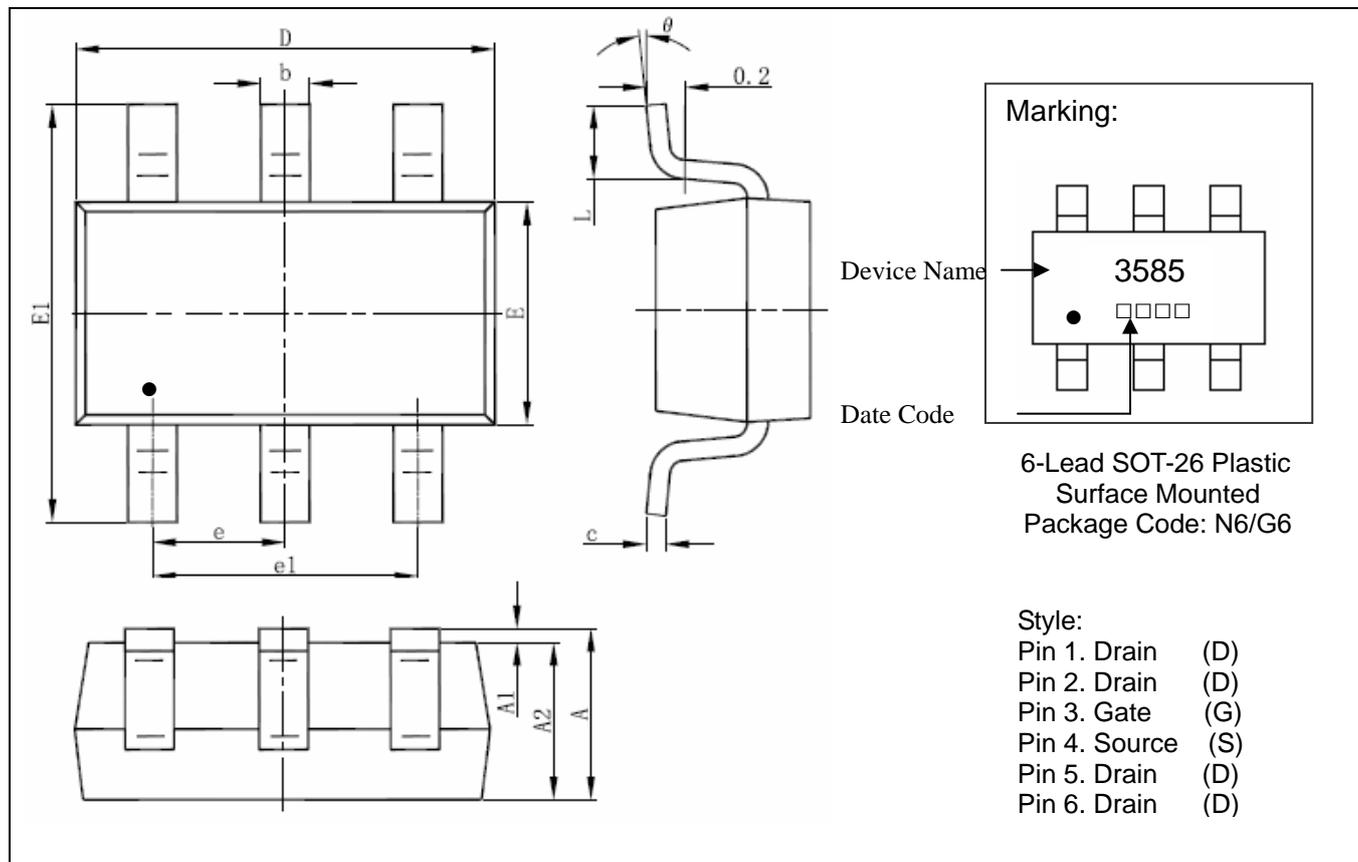
**Recommended temperature profile for IR reflow**



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T <sub>smax</sub> to T <sub>p</sub> )	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T <sub>s min</sub> )	100°C	150°C
-Temperature Max(T <sub>s max</sub> )	150°C	200°C
-Time(t <sub>s min</sub> to t <sub>s max</sub> )	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T <sub>L</sub> )	183°C	217°C
- Time (t <sub>L</sub> )	60-150 seconds	60-150 seconds
Peak Temperature(T <sub>P</sub> )	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

**SOT-26 Dimension**



DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	1.050	1.250	0.041	0.049	E	1.500	1.700	0.059	0.067
A1	0.000	0.100	0.000	0.004	E1	2.650	2.950	0.104	0.116
A2	1.050	1.150	0.041	0.045	e	0.950 (BSC)		0.037 (BSC)	
b	0.300	0.500	0.012	0.020	e1	1.800	2.000	0.071	0.079
c	0.100	0.200	0.004	0.008	L	0.300	0.600	0.012	0.024
D	2.820	3.020	0.111	0.119	θ	0°	8°	0°	8°